

Notice of References Cited	Application/Control No. 10/598,678		Applicant(s)/Patent Under Reexamination SKARBY ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,563,774 A	01-1986	Gloge, Detlef C.	398/166
*	B	US-4,649,549 A	03-1987	Halpern et al.	380/32
*	C	US-4,748,682 A	05-1988	Fukae et al.	455/137
*	D	US-5,216,434 A	06-1993	Fukumura, Yukio	343/876
*	E	US-5,248,988 A	09-1993	Makino, Mitsuya	343/792
*	F	US-5,280,472 A	01-1994	Gilhousen et al.	370/335
*	G	US-5,444,745 A	08-1995	Ali-Vehmas, Timo	375/347
*	H	US-5,513,176 A	04-1996	Dean et al.	370/335
*	I	US-5,533,011 A	07-1996	Dean et al.	370/342
*	J	US-5,742,583 A	04-1998	Scott, Logan	370/342
*	K	US-5,844,632 A	12-1998	Kishigami et al.	348/706
*	L	US-5,859,842 A	01-1999	Scott, Logan	370/342
*	M	US-5,926,503 A	07-1999	Kelton et al.	375/148

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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NON-PATENT DOCUMENTS

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	U	
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	X	

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,963,874 A	10-1999	Mahler, Hans	455/562.1
*	B	US-6,047,199 A	04-2000	DeMarco, Anthony T.	455/572
*	C	US-6,049,310 A	04-2000	Sadahiro, Keiichi	343/702
*	D	US-6,104,356 A	08-2000	Hikuma et al.	343/853
*	E	US-6,252,507 B1	06-2001	Gagnon, Andre	340/552
*	F	US-2001/0044323 A1	11-2001	Waylett, Nicholas S. A.	455/561
*	G	US-2002/0009982 A1	01-2002	Kim, Tae Wook	455/135
*	H	US-6,339,703 B1	01-2002	Otsuka, Yoshiaki	455/276.1
*	I	US-2002/0016152 A1	02-2002	Weissman et al.	455/16
*	J	US-6,522,307 B2	02-2003	Kim, Tae Wook	343/850
*	K	US-6,522,642 B1	02-2003	Scott, Logan	370/342
*	L	US-6,571,110 B1	05-2003	Patton et al.	455/561
*	M	US-2003/0139198 A1	07-2003	Johannisson et al.	455/525

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,621,469 B2	09-2003	Judd et al.	343/853
*	B	US-2004/0125741 A1	07-2004	Demoulin et al.	370/208
*	C	US-2004/0214608 A1	10-2004	Mostafa et al.	455/562.1
*	D	US-6,870,515 B2	03-2005	Kitchener et al.	343/853
*	E	US-6,868,254 B2	03-2005	Weissman, Haim	455/11.1
*	F	US-2005/0215288 A1	09-2005	Beaudin et al.	455/562.1
*	G	US-2005/0277387 A1	12-2005	Kojima et al.	455/078
*	H	US-2006/0003808 A1	01-2006	Haskell et al.	455/562.1
*	I	US-7,054,397 B1	05-2006	Kawanabe, Yoshitaka	375/347
*	J	US-2006/0111041 A1	05-2006	Karabinis, Peter D.	455/013.4
*	K	US-7,069,053 B2	06-2006	Johannisson et al.	455/562.1
*	L	US-7,123,939 B1	10-2006	Bird et al.	455/561
*	M	US-7,181,243 B1	02-2007	Nicholls et al.	455/561

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2007/0058761 A1	03-2007	Lindenmeier, Heinz	375/347
*	B	US-2007/0135169 A1	06-2007	Sychaleun et al.	455/562.1
*	C	US-2007/0173288 A1	07-2007	Skarby et al.	455/561
*	D	US-7,257,369 B2	08-2007	Weissman, Haim	455/11.1
*	E	US-7,272,417 B2	09-2007	Mostafa et al.	455/562.1
*	F	US-2008/0026796 A1	01-2008	Thomas, Louis David	455/562.1
*	G	US-2008/0119197 A1	05-2008	Skarby, Ulf	455/446
*	H	US-2008/0287163 A1	11-2008	Skarby et al.	455/562.1
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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